

United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/826,838	04/06/2001	Chan-Hoon Park	SEC.832	5078
75	590 03/24/2004		EXAM	INER
JONES VOLENTINE, L.L.C.			NGUYEN, HUNG	
SUITE 150 12200 SUNRIS	SE VALLEY DRIVE		ART UNIT	PAPER NUMBER
RESTON, VA	20191		2851	

DATE MAILED: 03/24/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

•			V		
	Application No.	Applicant(s)			
	09/826,838	PARK, CHAN-HO	PARK, CHAN-HOON		
Office Action Summary	Examiner	Art Unit			
	Hung Henry V Nguyen	2851			
The MAILING DATE of this communication app Period for Reply	pears on the cover sheet	with the correspondence ad	dress		
A SHORTENED STATUTORY PERIOD FOR REPL' THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.1 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a repl If NO period for reply is specified above, the maximum statutory period of the p	36(a). In no event, however, may a y within the statutory minimum of the will apply and will expire SIX (6) MC at cause the application to become a	a reply be timely filed hirty (30) days will be considered timel DNTHS from the mailing date of this control (35 U.S.C. § 133).	y. ommunication.		
Status					
1) Responsive to communication(s) filed on 06 A	<u>pril 2001</u> .		-		
,_	action is non-final.				
	, 				
closed in accordance with the practice under be	Ex [*] parte Quayle, 1935 C.	.D. 11, 453 O.G. 213.			
Disposition of Claims					
 4) Claim(s) 1-8 is/are pending in the application. 4a) Of the above claim(s) is/are withdra 5) Claim(s) is/are allowed. 6) Claim(s) 1-8 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/or 					
Application Papers			•		
9) The specification is objected to by the Examine 10) The drawing(s) filed on <u>06 April 2001</u> is/are: a Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the Ex) accepted or b)⊠ obj drawing(s) be held in abey tion is required if the drawir	ance. See 37 CFR 1.85(a). ng(s) is objected to. See 37 C			
Priority under 35 U.S.C. § 119					
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority document 2. Certified copies of the priority document 3. Copies of the certified copies of the priority application from the International Burea * See the attached detailed Office action for a list	ts have been received. ts have been received in rity documents have bee u (PCT Rule 17.2(a)).	Application No en received in this National	Stage		
Attachment(s) 1) Notice of References Cited (PTO-892)		v Summary (PTO-413)			
 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date 4/2001. 		o(s)/Mail Date If Informal Patent Application (PTo	O-152)		

Application/Control Number: 09/826,838

Art Unit: 2851

DETAILED ACTION

Drawings

1. This application, filed under former 37 CFR 1.60, lacks formal drawings. The informal drawings filed in this application are acceptable for examination purposes. When the application is allowed, applicant will be required to submit new formal drawings. In unusual circumstances, the formal drawings from the abandoned parent application may be transferred by the grant of a petition under 37 CFR 1.182.

Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 1-8 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ausschnit et al (U.S.Pat. 5,965,309) in view of Yoshioda et al (U.S.Pat. 6,051,349).

With respect to claims 1-8, Ausschnit et al discloses a system (see figures 19 and 20) for adjusting photo-exposure conditions in a semiconductor manufacturing (see col.1, lines 15-33 and figure 19) and substantially comprising all basic features of the instant claims such as: a photo-exposure unit (see col.17, 5-10, see figures 19-20) for adjusting photo exposure conditions of a photo-exposure step performed on a semiconductor device in the semiconductor manufacturing apparatus based on one or more adjustment signals; a pre-exposure step influence prediction unit (see col.17, lines 15-19) for obtaining information regarding a semiconductor

Application/Control Number: 09/826,838

Art Unit: 2851

device in the manufacturing apparatus during a pre-exposure processing before the device is subjected to the photo-exposure step, the information including a value of a factor that affects a line width of a line formed on the semiconductor device in the photo-exposure step such as focus, exposure rate, and providing that information as feed forward data; an inspection unit (see col.17, lines 18-19; see col.19, line 23- through col.28, line 39) for generating an inspection value by measuring an aspect of the semiconductor device after it has been subjected to the photo-exposure step and providing the inspection value as feed back data, and a central processing unit (see col.17, lines 20-22; col.21, line 15 through col.22 line) for receiving the feed forward data and the feed back data and generating one or more adjustment signals based on the feed forward data and feed back data wherein the feed forward data is obtained by quantifying the obtained information and one or more adjustment signals are transmitted to the photo exposure unit via a processing unit in a real time or the signals are generated via calculated formula (see col.21, lines 30-45, for example). Ausschnit et al, thus, clearly teaches apparatus and corresponding method for processing photo-exposure by "adjusting exposure conditions" such as photo-exposure rate through feedback. Ausschnit does not expressly disclose adjusting a photo-exposure time for changing processing conditions (for example, in line width) "in accordance with one or more adjustment signals". Yoshioka teaches an exposure control apparatus in a lithographic system having a photo-exposure unit (1,22) and a CPU (45) for obtaining the temperature data of the post baking temperature unit or the developing solution temperature based on the line width of the resist film/ patter size, and a sensor (65) is disposed within the resist coating and developing unit to obtain the line width of the resist film. Yoshioka teaches the information on the measurement of the line width is fed back so as to control at least

Application/Control Number: 09/826,838

Art Unit: 2851

one of the resist coating condition, temperature of the resist solution...the light exposure conditions such as the light exposure time, and the focal length (see col.12, lines 44-54). Yoshioka, then teaches the CPU (45) delivers a command signal to the light exposure device to control the exposure time based on the results of the line width measurement (see col.15, lines 15-22). As such, Yoshioka clearly teaches controlling of exposure time in response to a line width. In view of such teachings, it would have been obvious to one having ordinary skill in the art at the time the invention was made to incorporate the teachings of Ausschnitt et al and Yoshioka et al to obtain the invention as specified in claims 1-8 of the present invention. It would have been obvious to a skilled artisan to apply and adjust the exposure time in response to a line width as suggested by Yoshioka into the system of Ausschinit et al for the purpose of improving the resolution of the images to be printed whereby the quality of the system is greatly obtained.

Prior Art Made of Record

4. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Ogata (U.S.Pat. 6,221,787) teaches an apparatus of forming resist film where the exposure time is controlled based on the detected thickness of the resist film. Therefore, the line width of a resist pattern can be precisely controlled (see claim 1 and 8).

Application/Control Number: 09/826,838 Page 5

Art Unit: 2851

5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Hung Henry V Nguyen whose telephone number is 571-272-2124. The examiner can normally be reached on Monday-Friday (First Friday off).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Russ Adams can be reached on 571-272-2112. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

hvn 3/12/04

VHENRY MUNG NGUYEN
PRIMARY EXAMINER